



Measurement of Transmittance, Emission and Light Output for PWO Crystals

Ren-yuan Zhu

California Institute of Technology



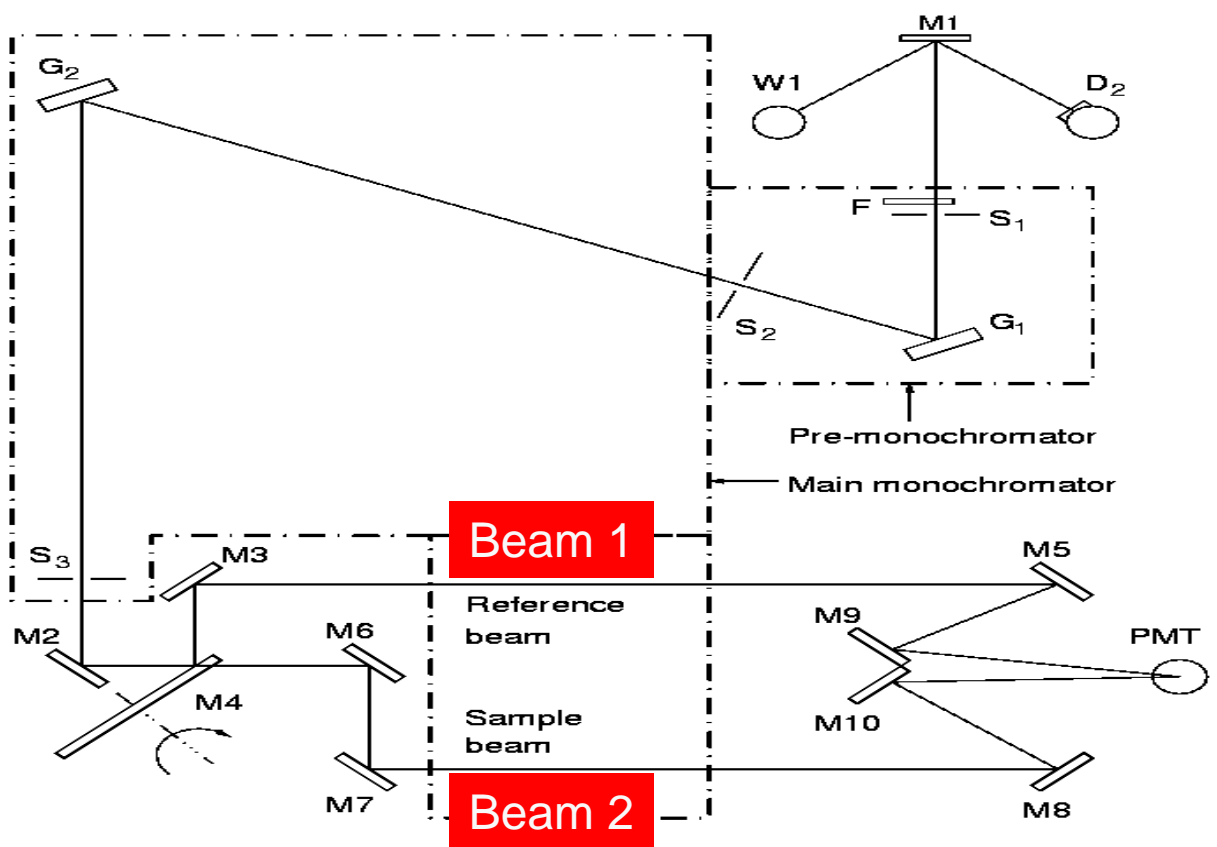
Introduction



- Recent data shows following concerns on SIC PWO samples: 1) absorption; 2) red emission; 3) emission variation after irradiation; and 4) strange recovery in light output after irradiation.
- Although no new samples received, a series tests were made at Caltech with existing PWO samples to understand these concerns.
- With result presented in this report, we hope to clean up the confusion.
- Unless specified, all samples in this report are produced in 2001 and 2002 by BTCP and SIC respectively.

Transmittance Measurement

HITACHI U-3210 UV/VIS Spectrophotometer with a Large Sample Compartment



A simple way for looking absorption bands. No controversy.

Precision of 0.3% can be reached.

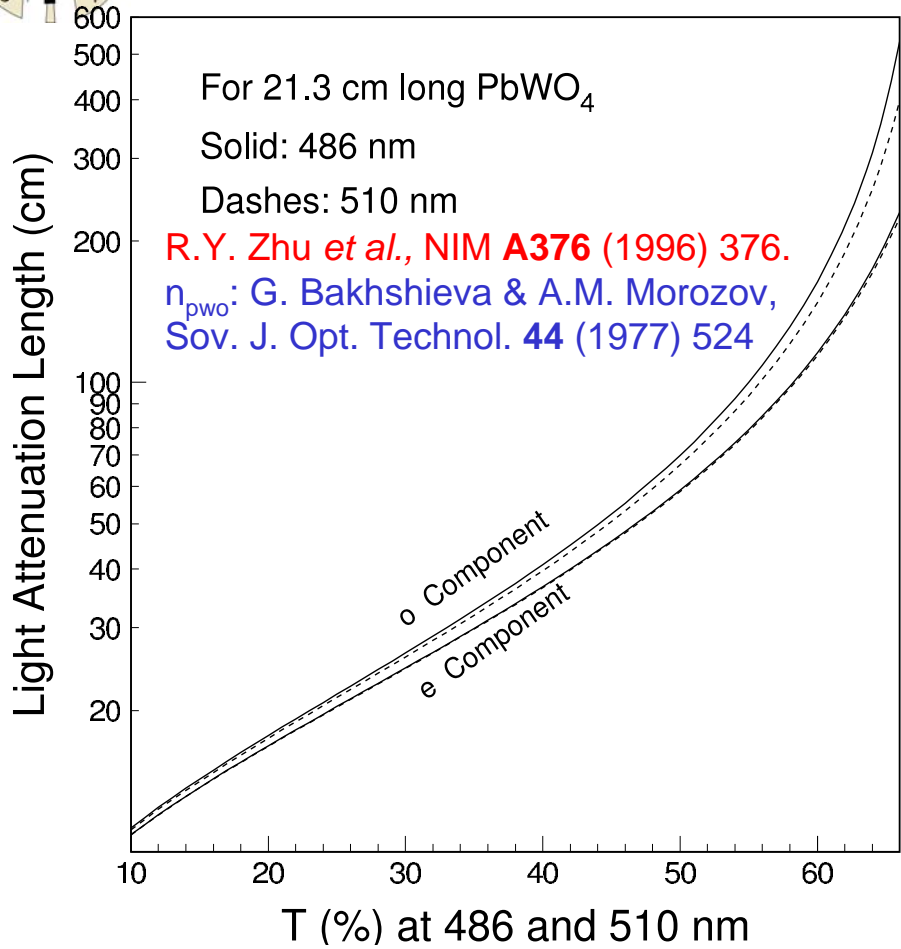
Issue for PWO: birefringence.

$$T_s = (1 - R)^2 + R^2(1 - R)^2 + \dots = (1 - R)/(1 + R), \text{ with}$$

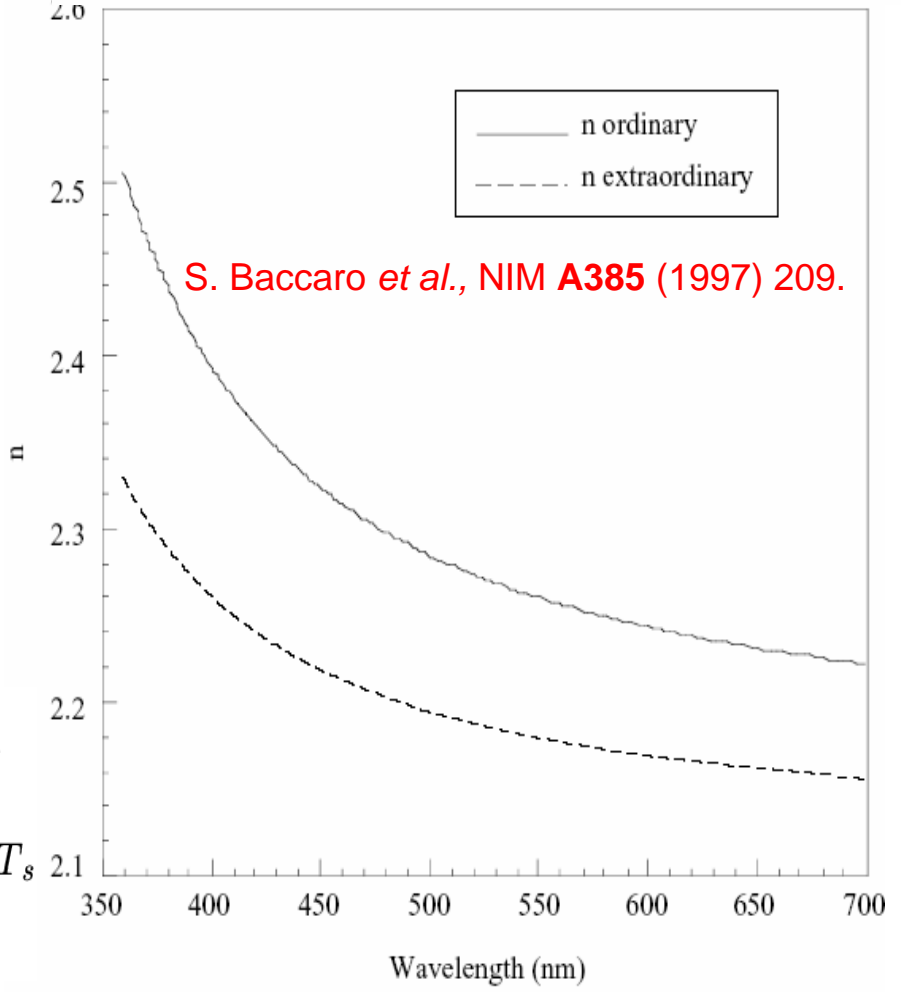
$$R = \frac{(n_{crystal} - n_{air})^2}{(n_{crystal} + n_{air})^2}.$$

Theoretical limit: D.A. Ma *et al.*, NIM A333 (1993) 422

PWO is Birefringent



λ (nm)	n_o	n_e
375	2.452±0.009	2.297±0.025
400	2.393±0.009	2.260±0.019
425	2.353±0.009	2.236±0.015
450	2.323±0.009	2.218±0.013
475	2.301±0.009	2.205±0.011
500	2.284±0.009	2.194±0.010



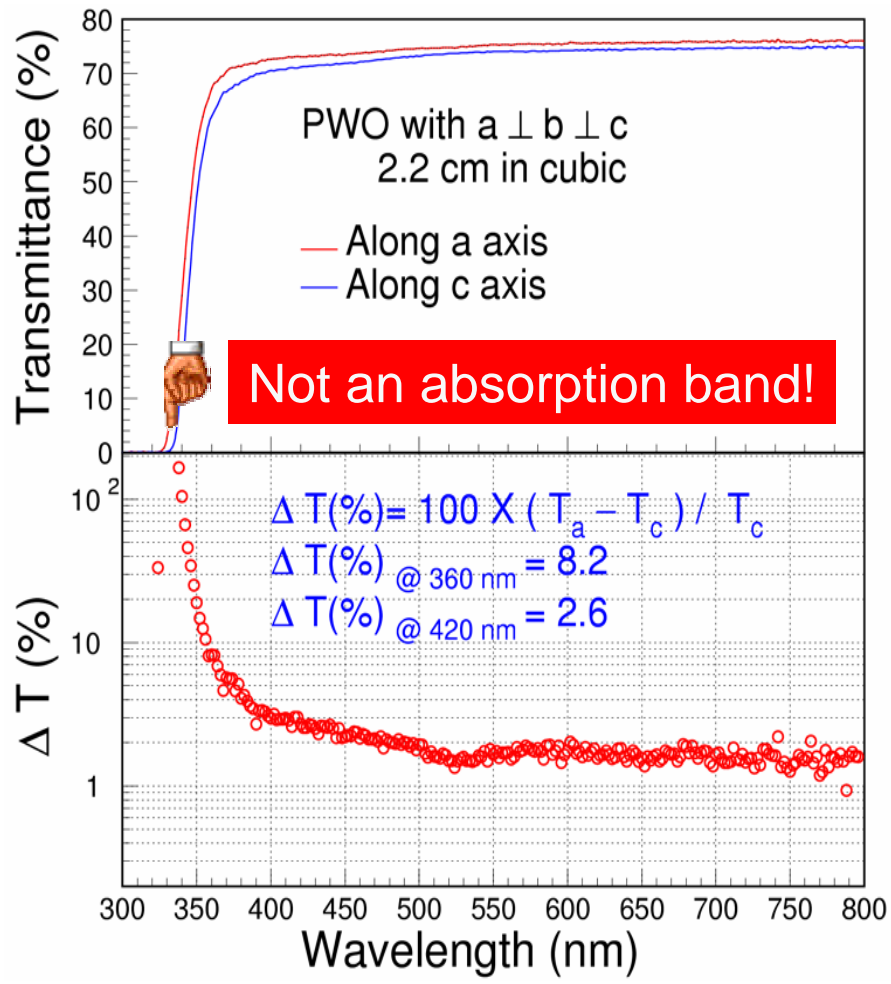
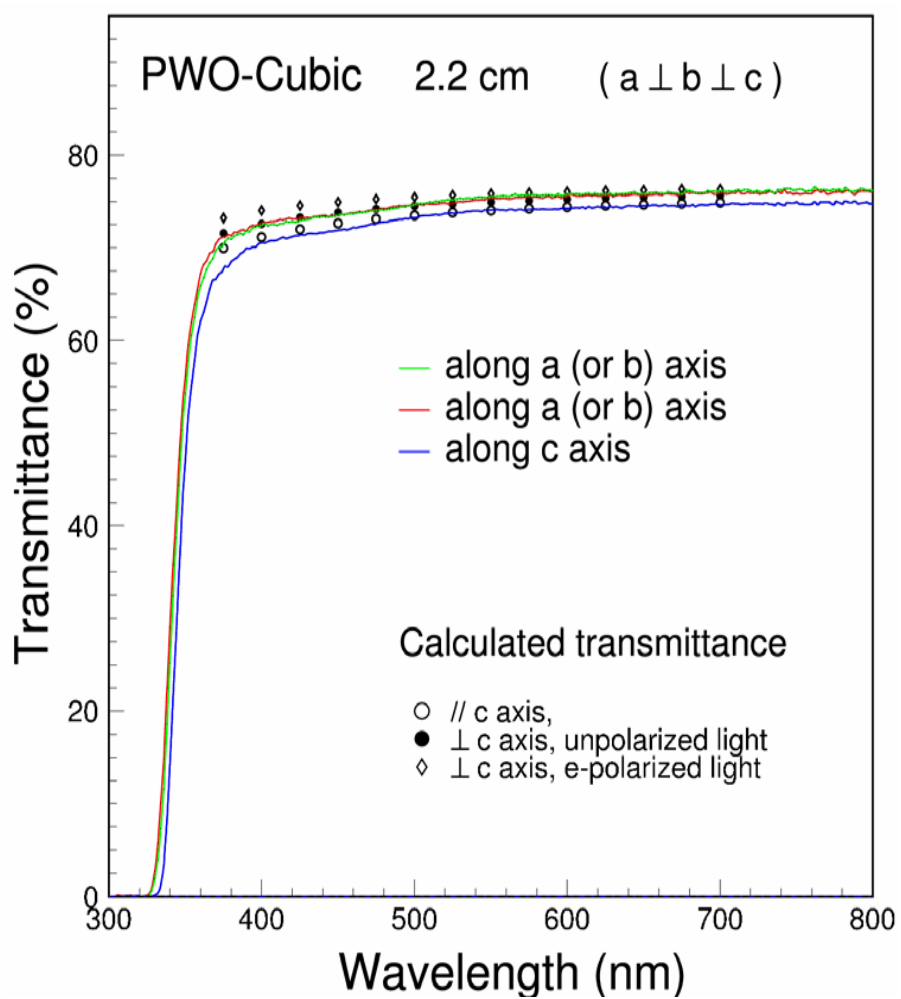
$$LAL = \frac{\ell}{\ln\left\{\frac{T(1 - T_s)^2}{\sqrt{4T_s^4 + T^2(1 - T_s^2)^2} - 2T_s^2}\right\}}$$

where T is transmittance measured along crystal length ℓ and T_s is the theoretical transmittance without internal absorption:

D.A. Ma *et al.*, NIM **A333** (1993) 422

Transmittance of a PWO Cube

Transmittances measured along the *c* and *a* axis are **NOT** directly comparable



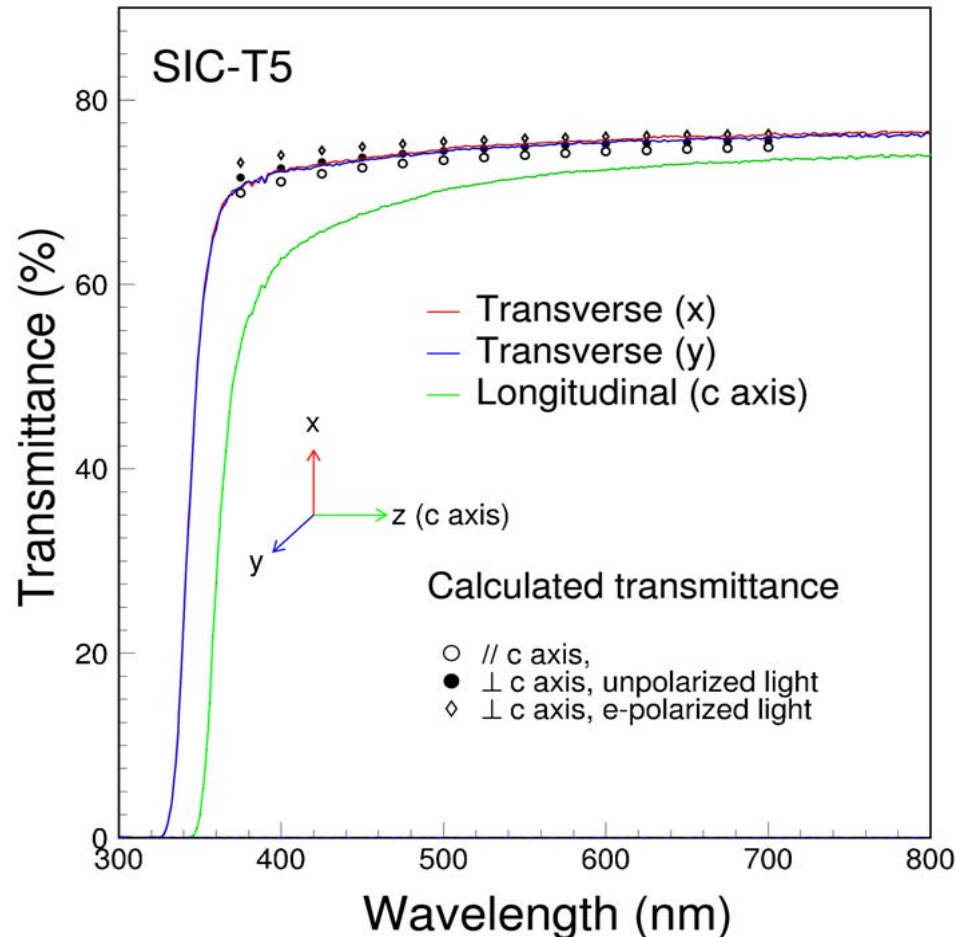
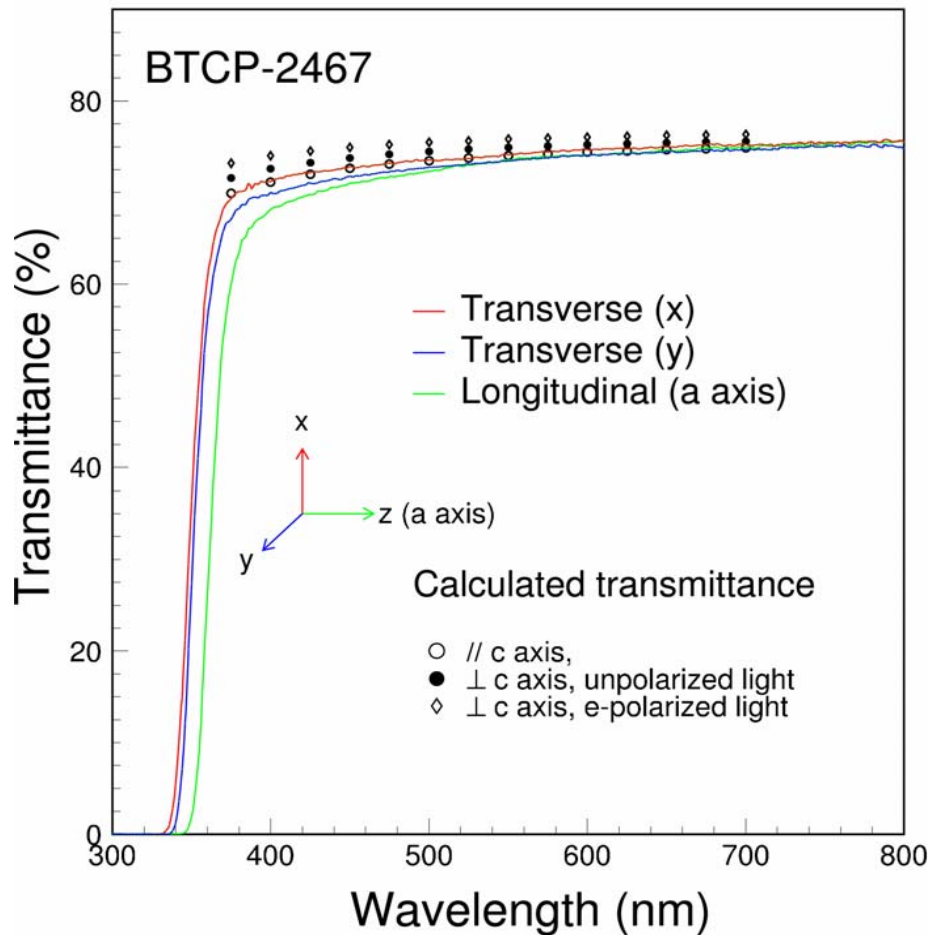
Transmittance of CMS Samples

a axis: better L.T., but non-isotropic T. T.

Both approaching theoretical limit

BTCP: grown along the **a axis**

SIC: grown along the **c axis**



Radio-Luminescence Measurement

Issue: Absorption affects emission blue edge

Corrections: Grating efficiency & PMT (Hamamatsu R758) QE

R.Y. Zhu *et al.*, NIM A376 (1996) 376

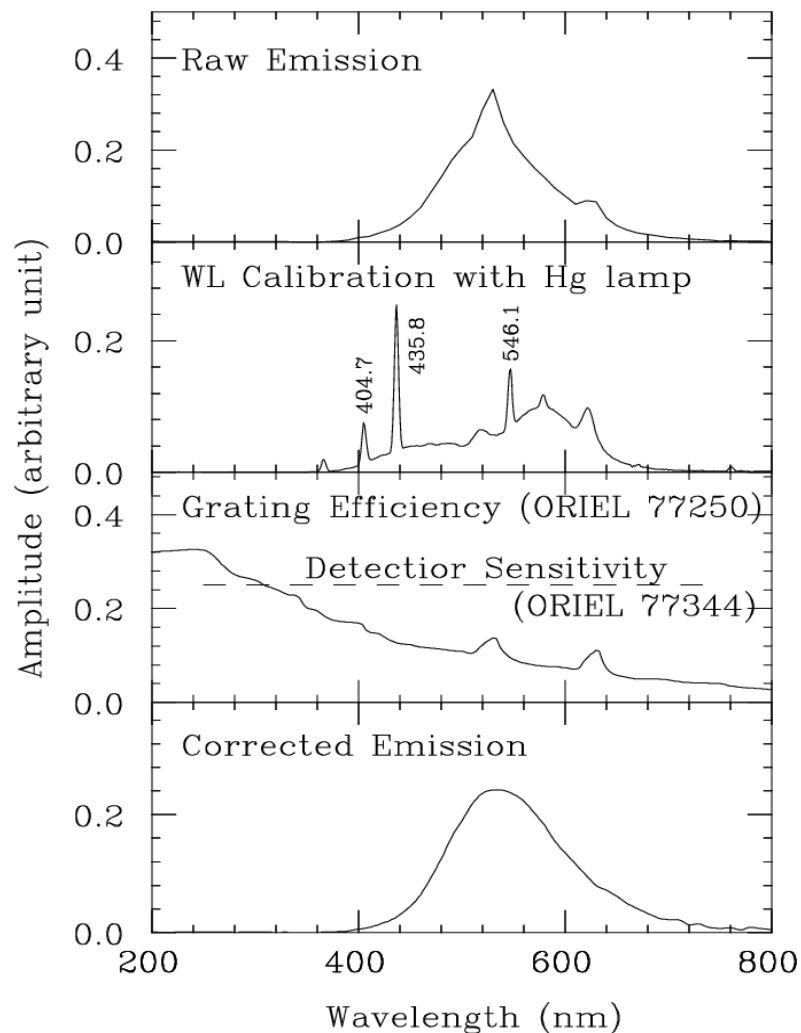
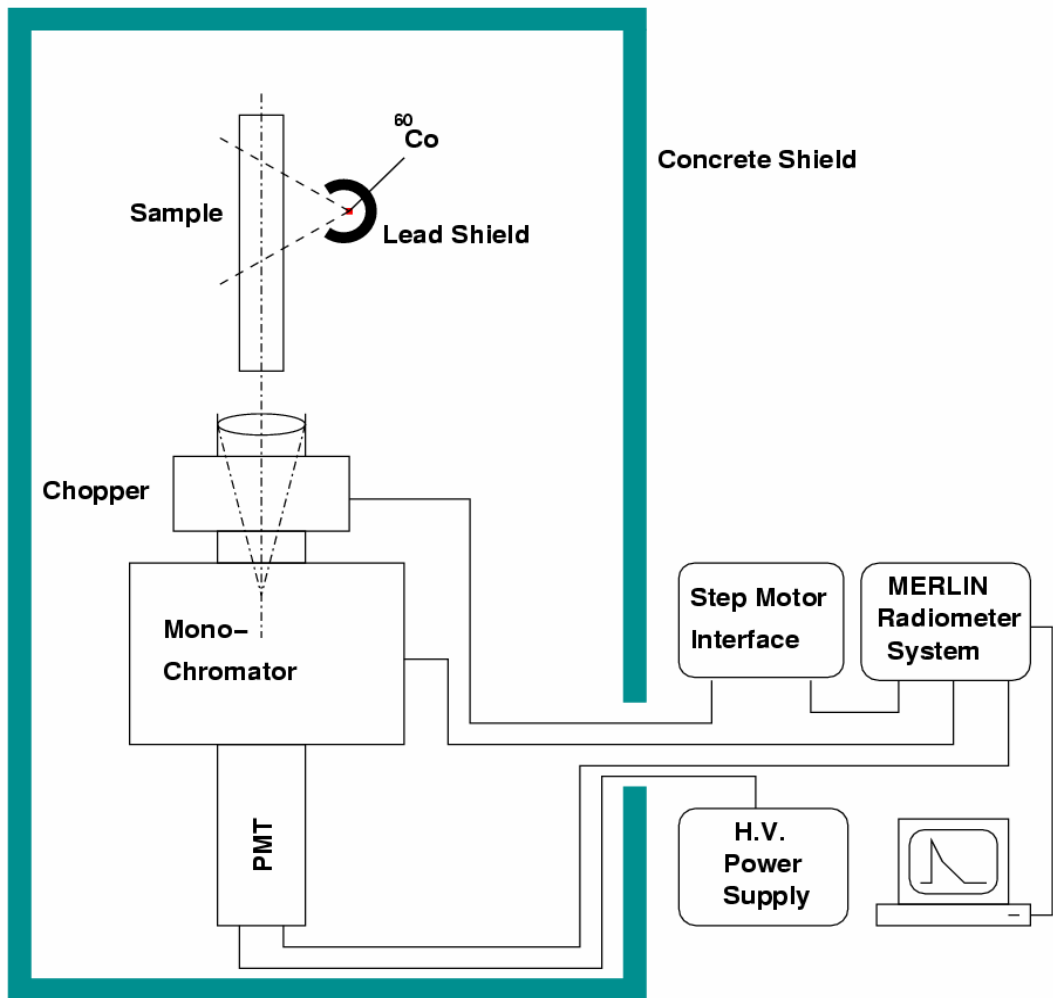
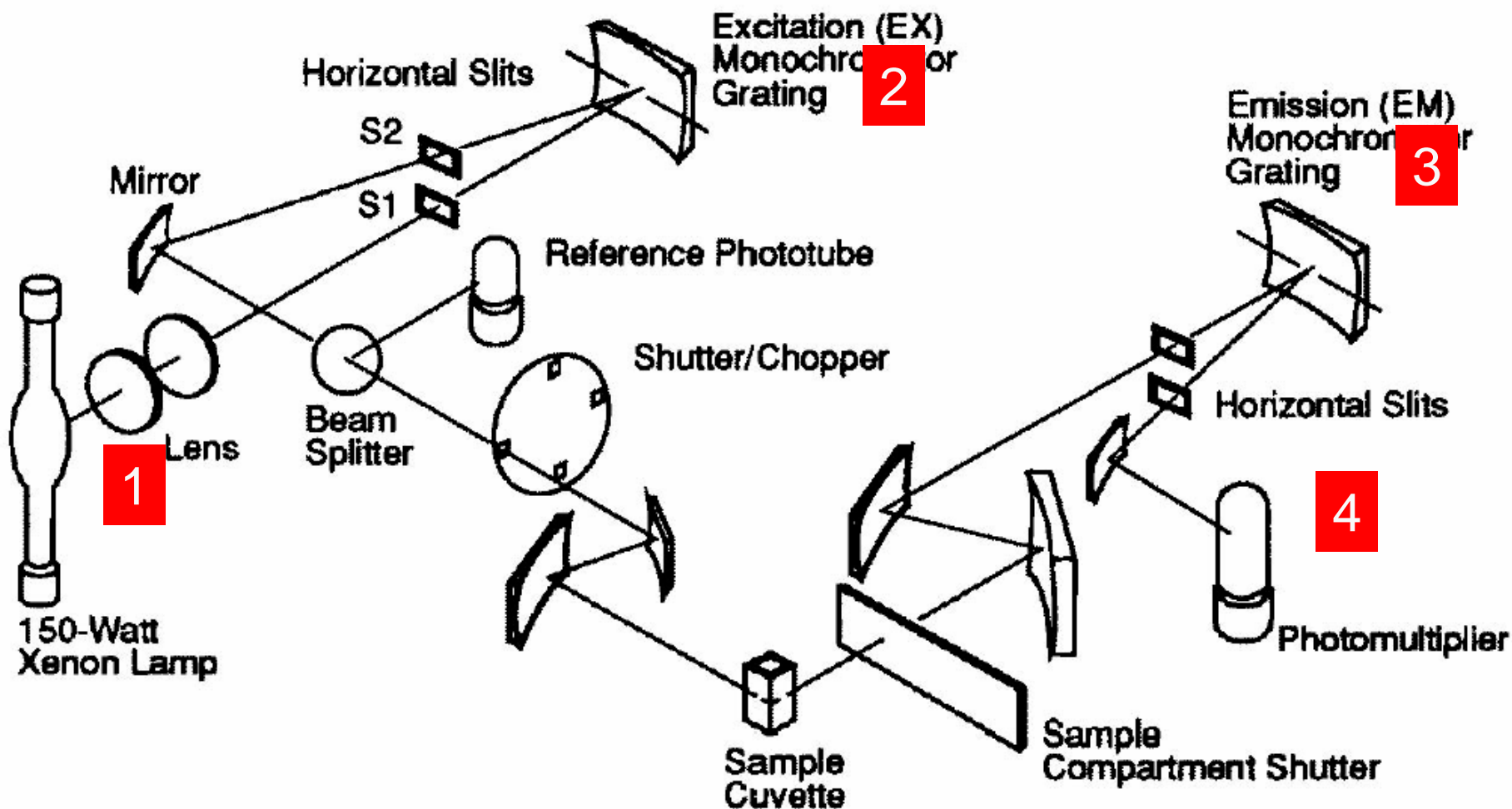


Photo Luminescence Measurement

HITACHI F4500 Fluorescence Spectrophotometer

Light Source (1), Gratings Efficiencies (2 & 3) & PMT QE (4)

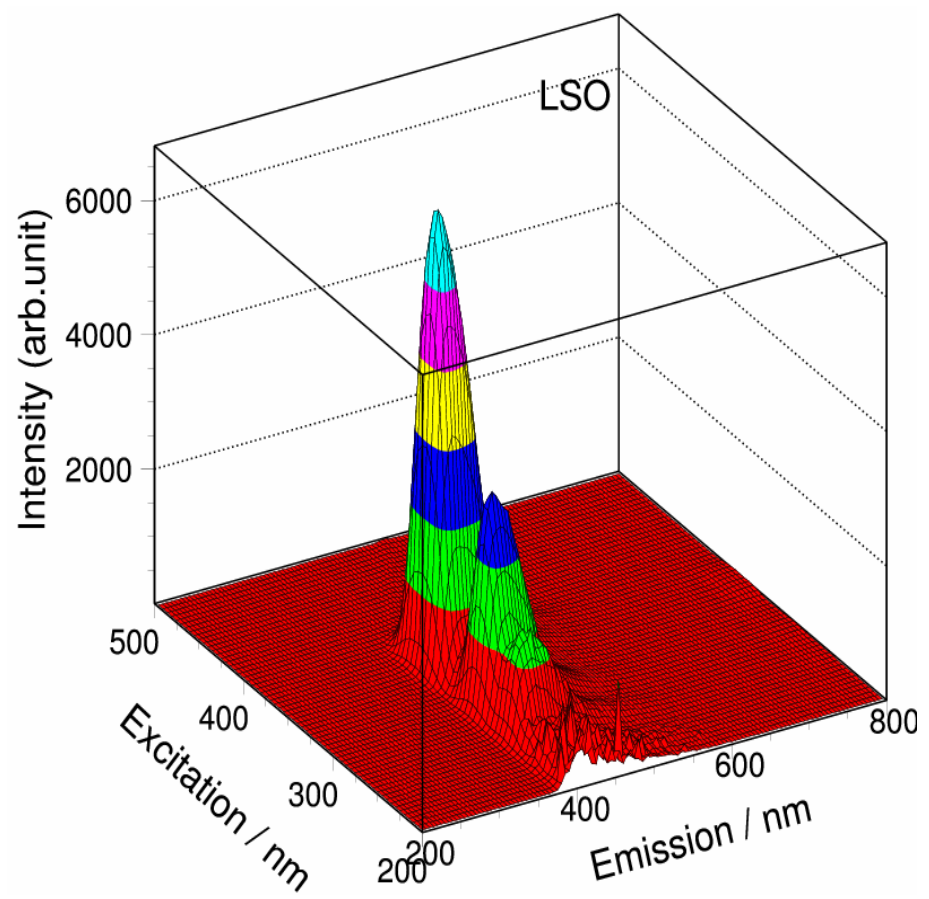
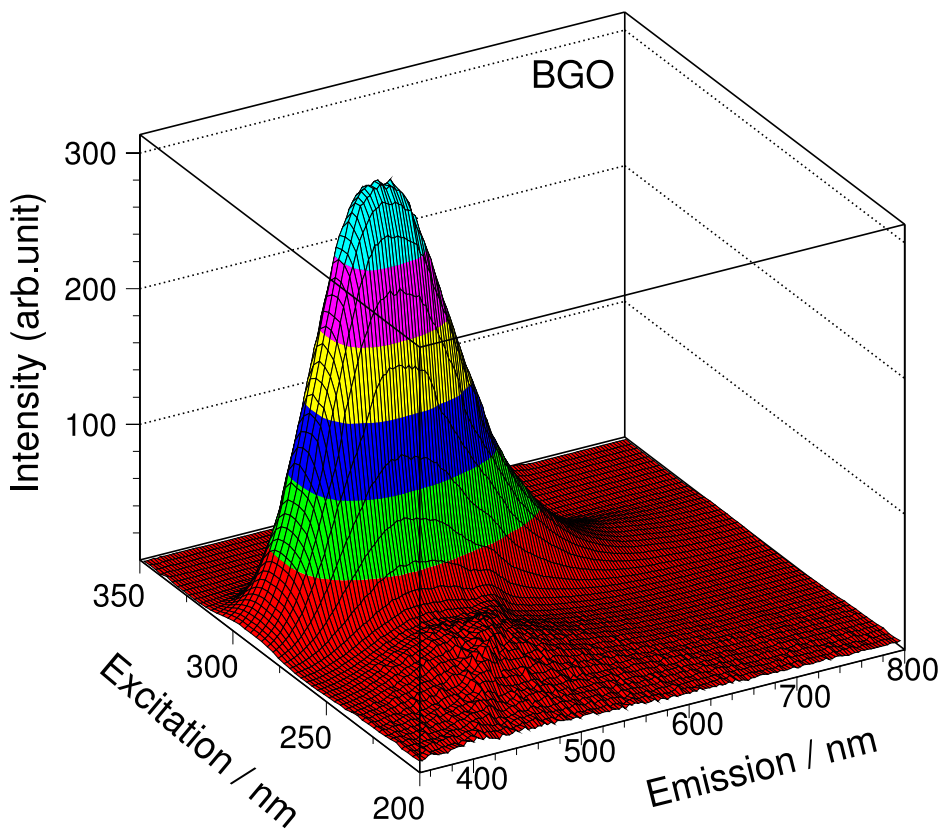
Red-Extended Hamamatsu R928 PMT(4): 185 to 900 nm



3-Dimensional Contour for Emission & Excitation

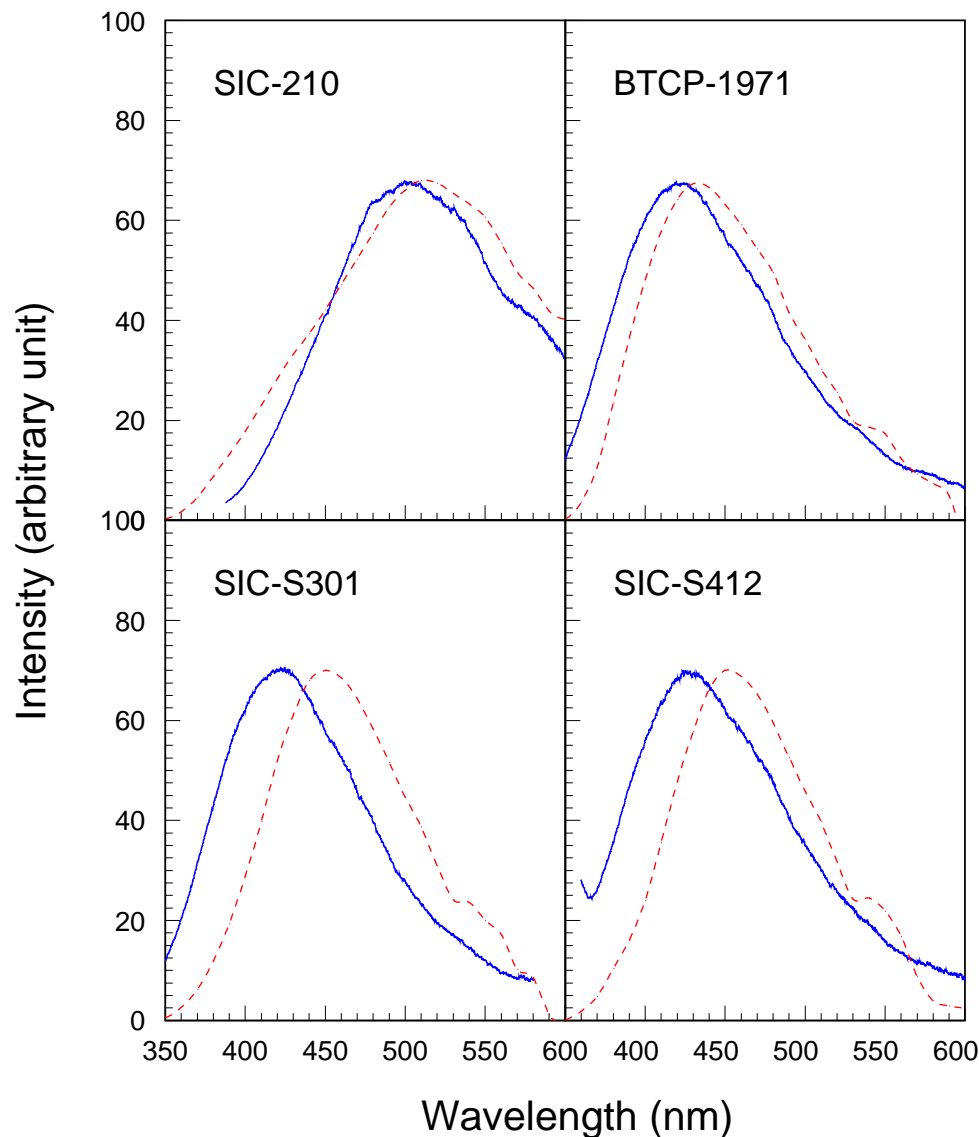
Measured by using HITACHI F4500

No controversy for bright scintillators



Radio & Photo Luminescence

X.D. Qu *et al.*, IEEE Trans. Nucl. Sci. **NS-47** (2000) 1741



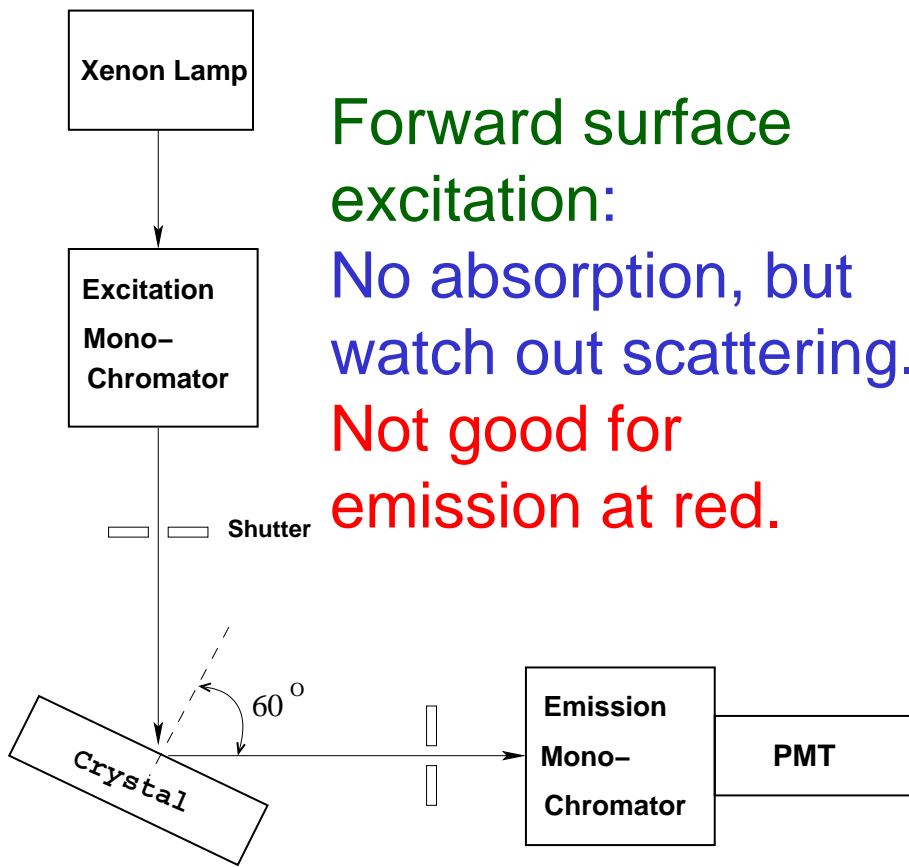
Radio luminescence has a red shift as compared to photo luminescence because of internal absorption.

Photo luminescence has a red tail caused by scattering.

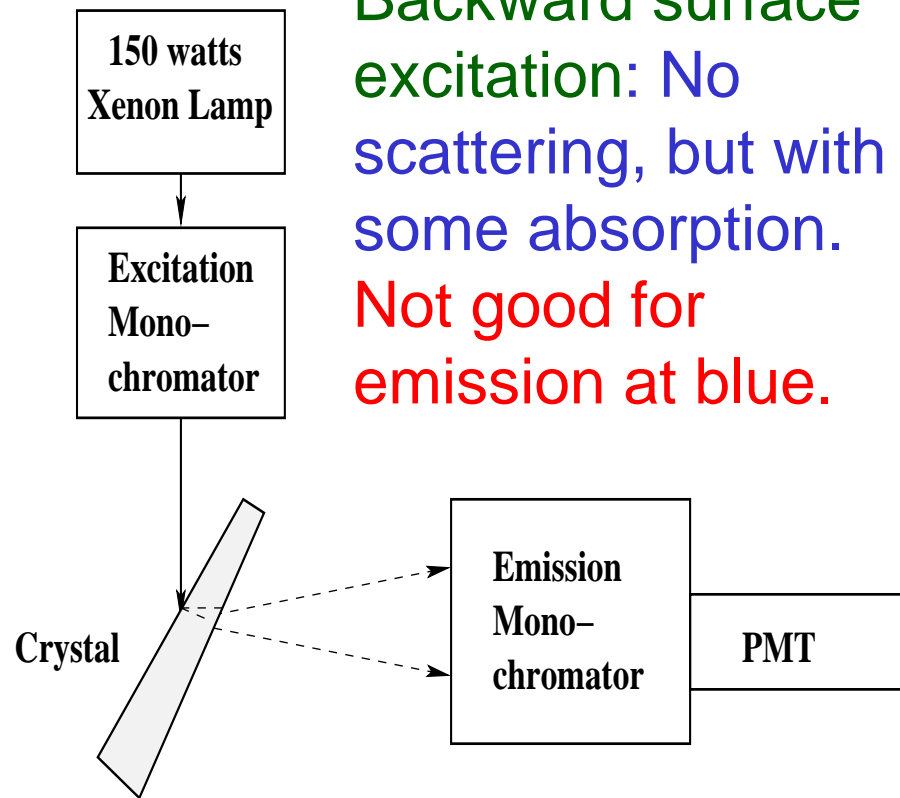
Photo-luminescence Measurement

Issues: excitation light and its scattering light may pass emission grating at multiple wavelength, causing artificial peaks at red for PWO.

Forward surface excitation:
 No absorption, but watch out scattering.
 Not good for emission at red.

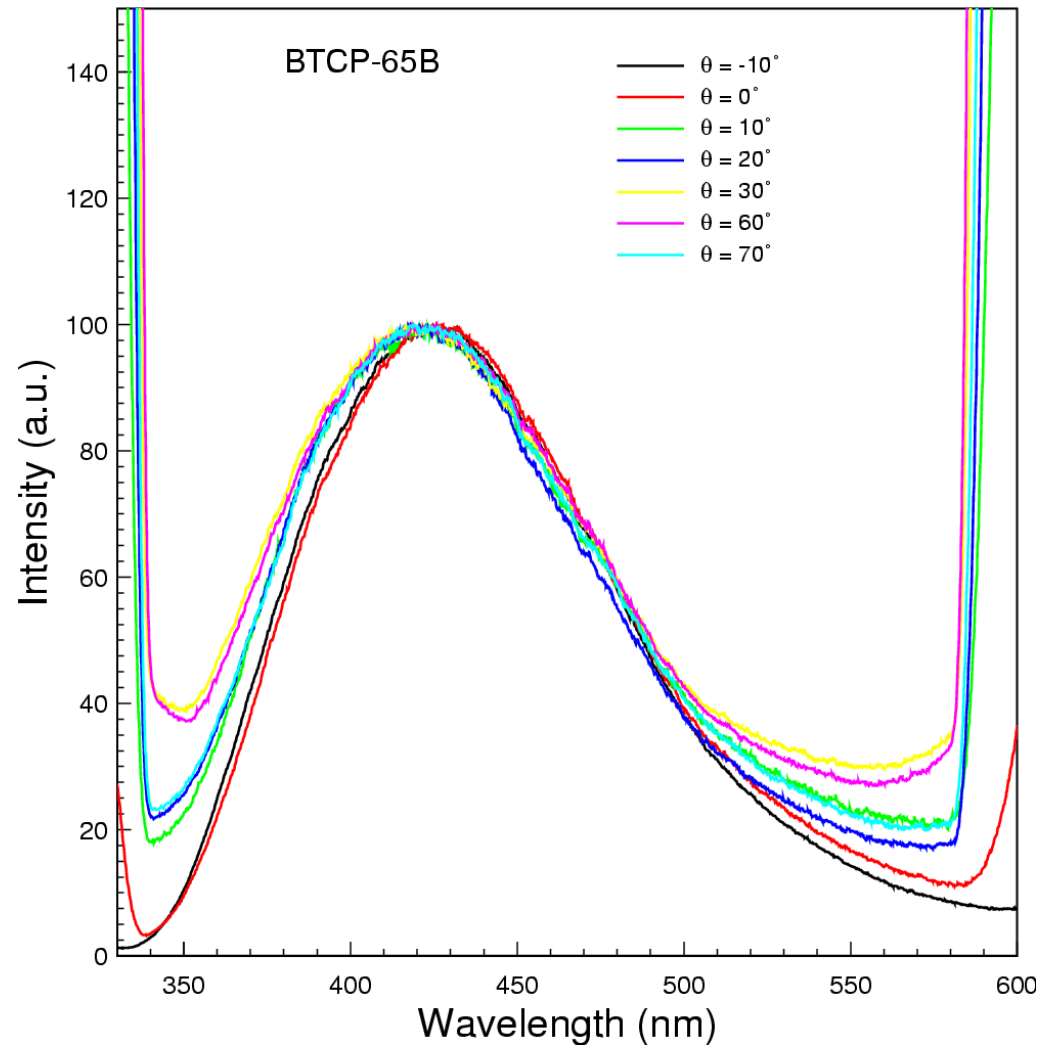
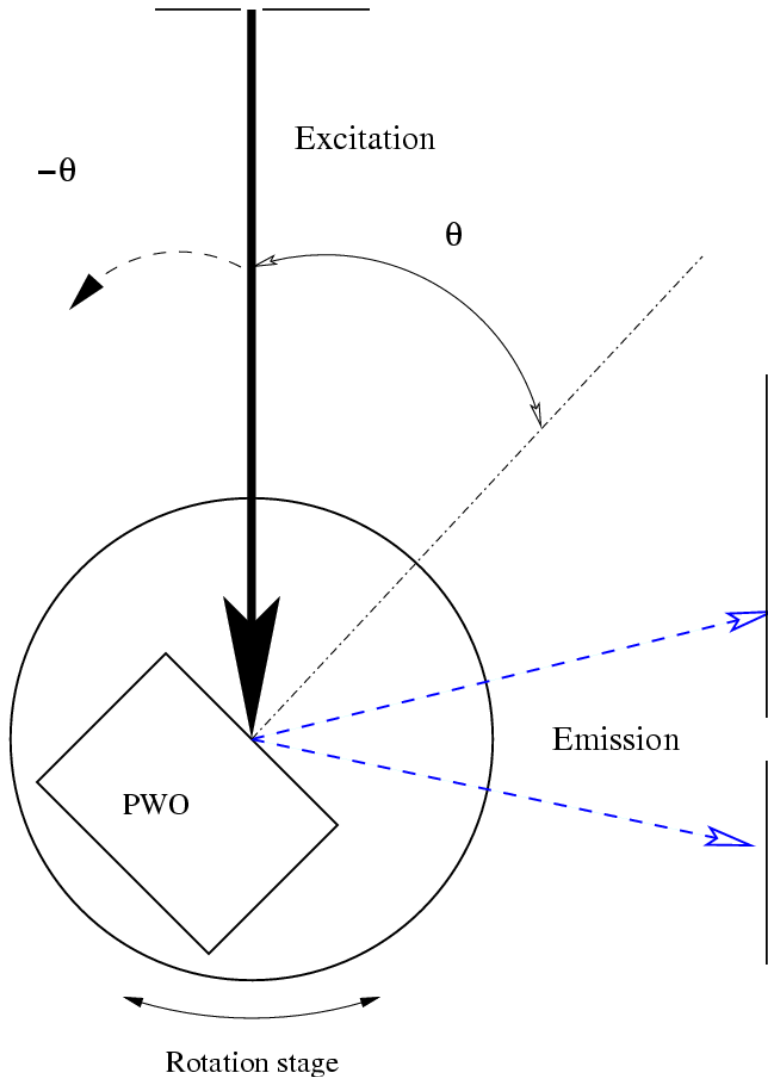


Backward surface excitation: No scattering, but with some absorption.
 Not good for emission at blue.



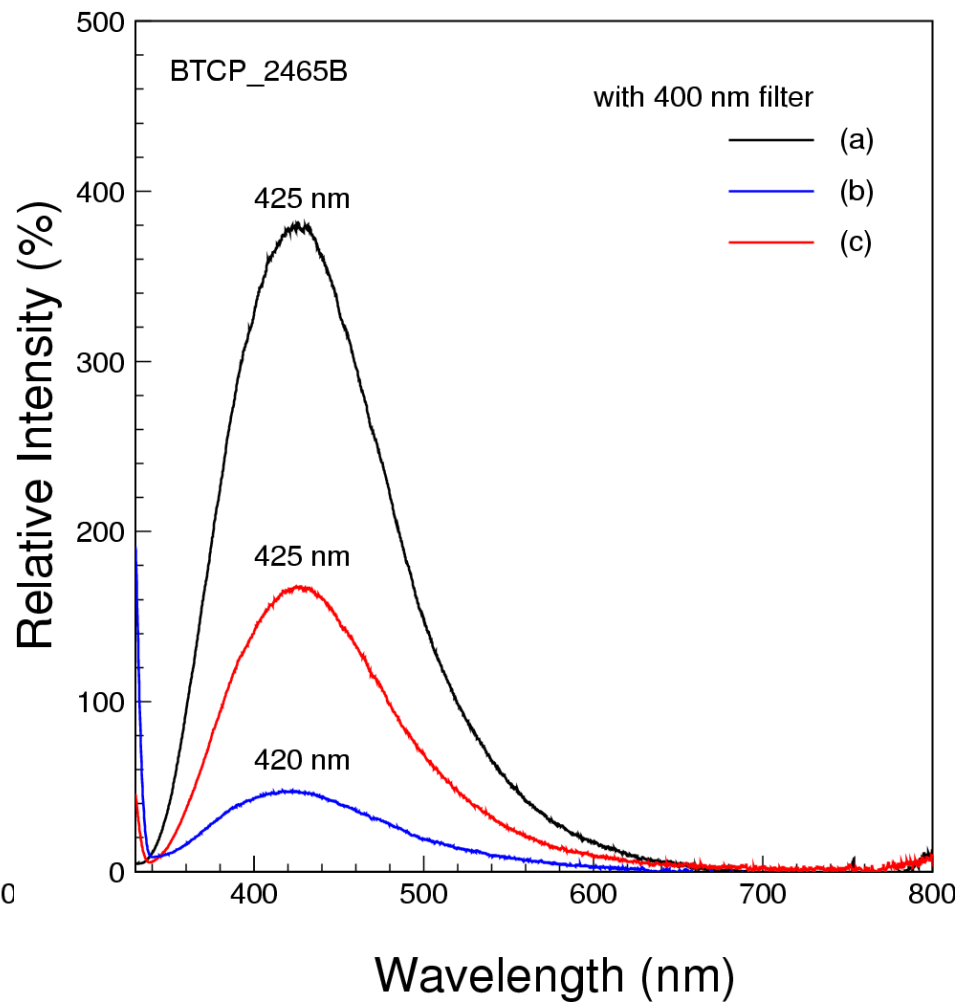
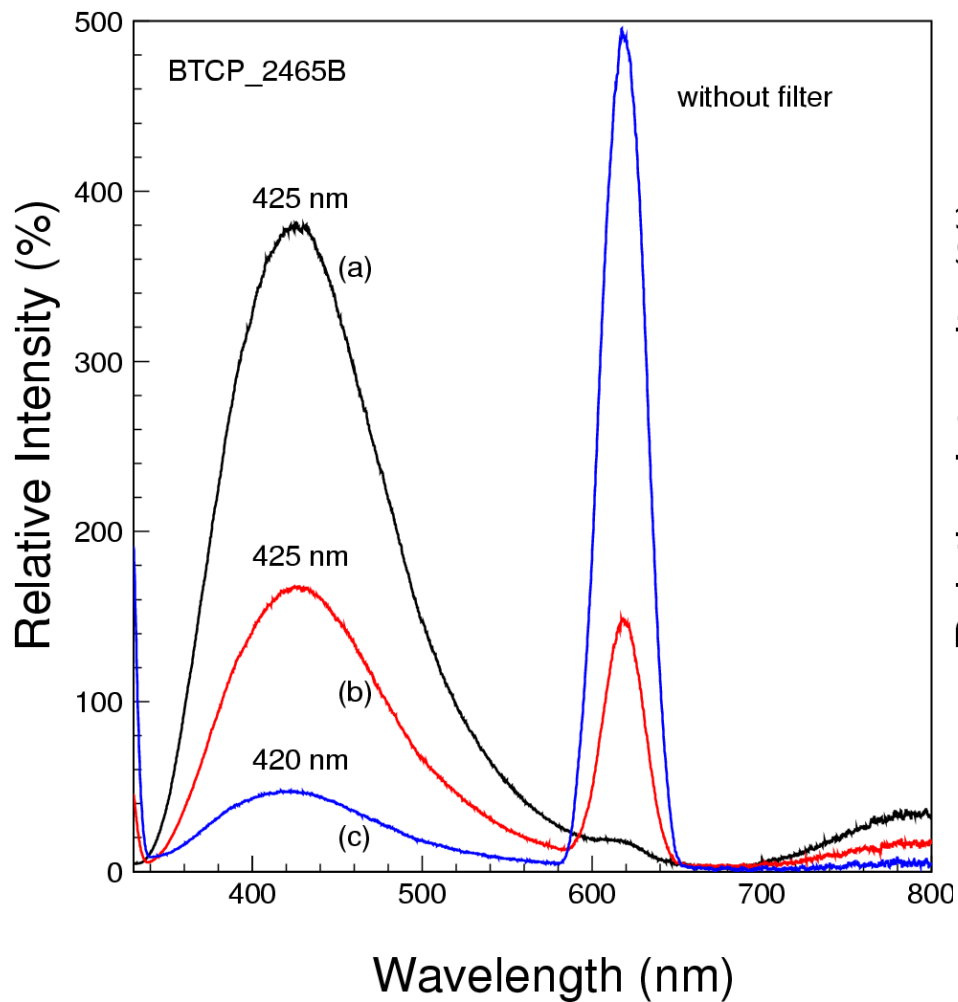
Scattering & Incident Angle

Backward surface excitation reduces scattering



Red Peak May Caused by Scattering

A low pass filter may eliminate scattering



Full Wavelength: 350 to 800 nm

No red emission observed in BTCP & SIC samples

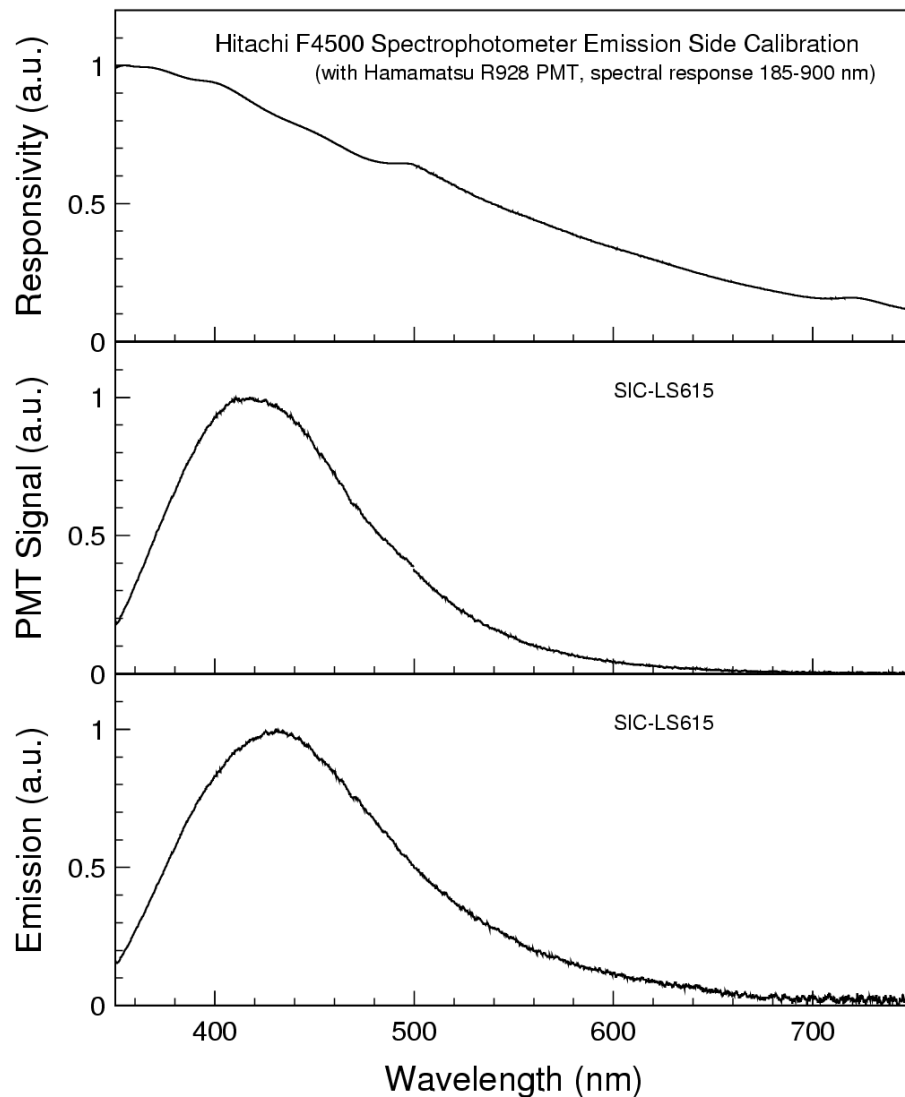
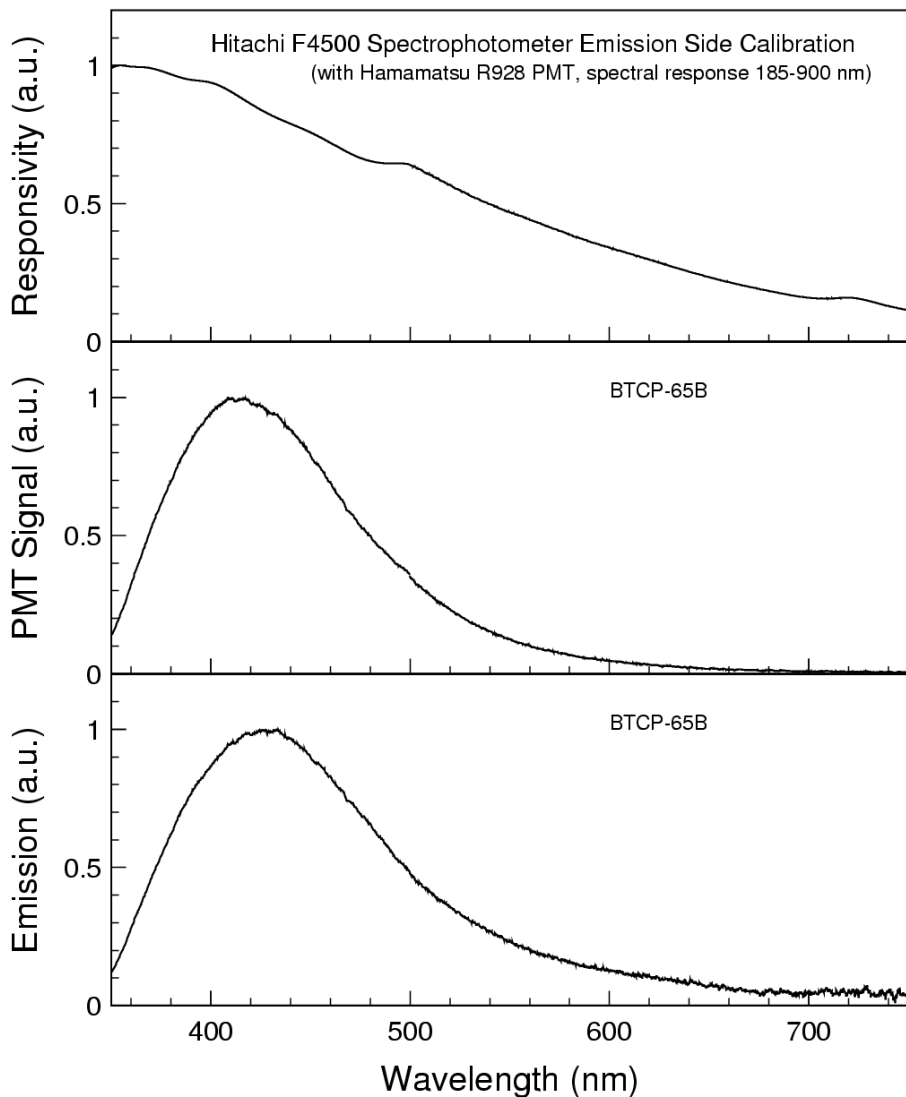


Photo Luminescence (350-550 nm)

No variation in either excitation or emission spectrum
No damage in scintillation mechanism

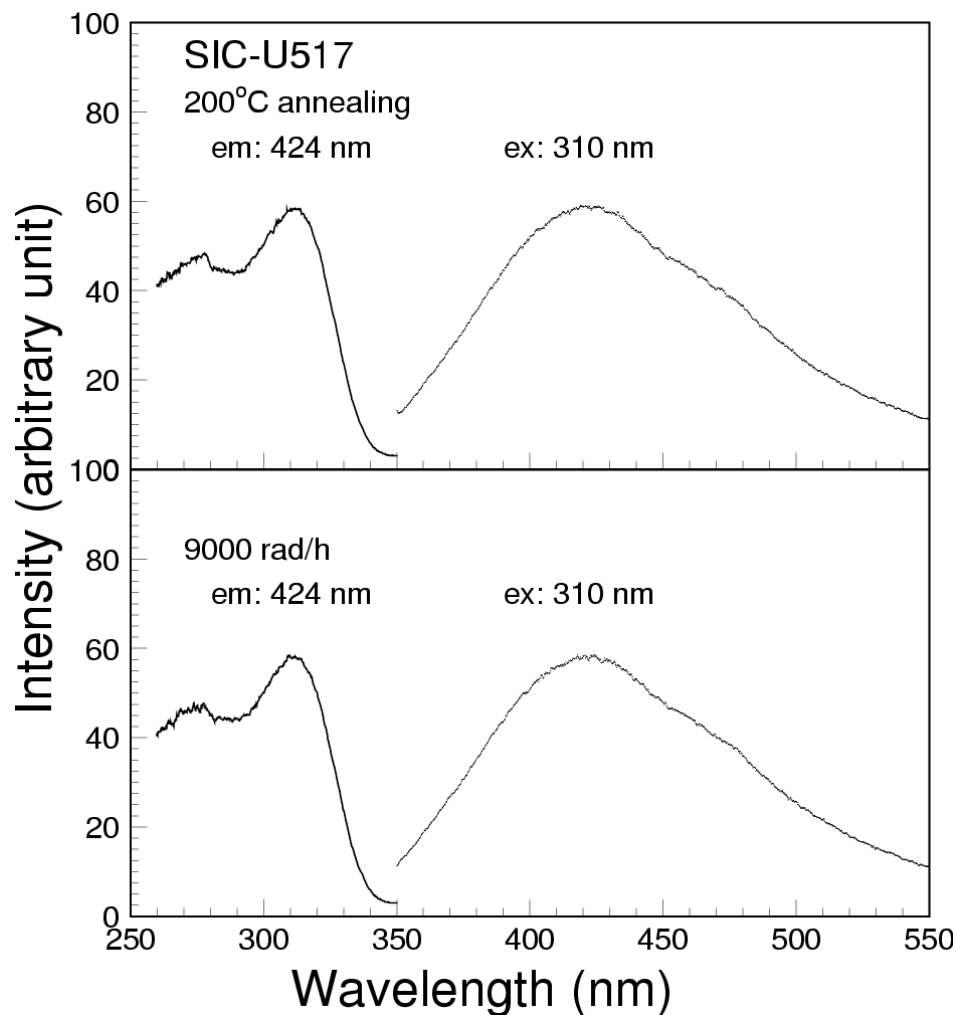
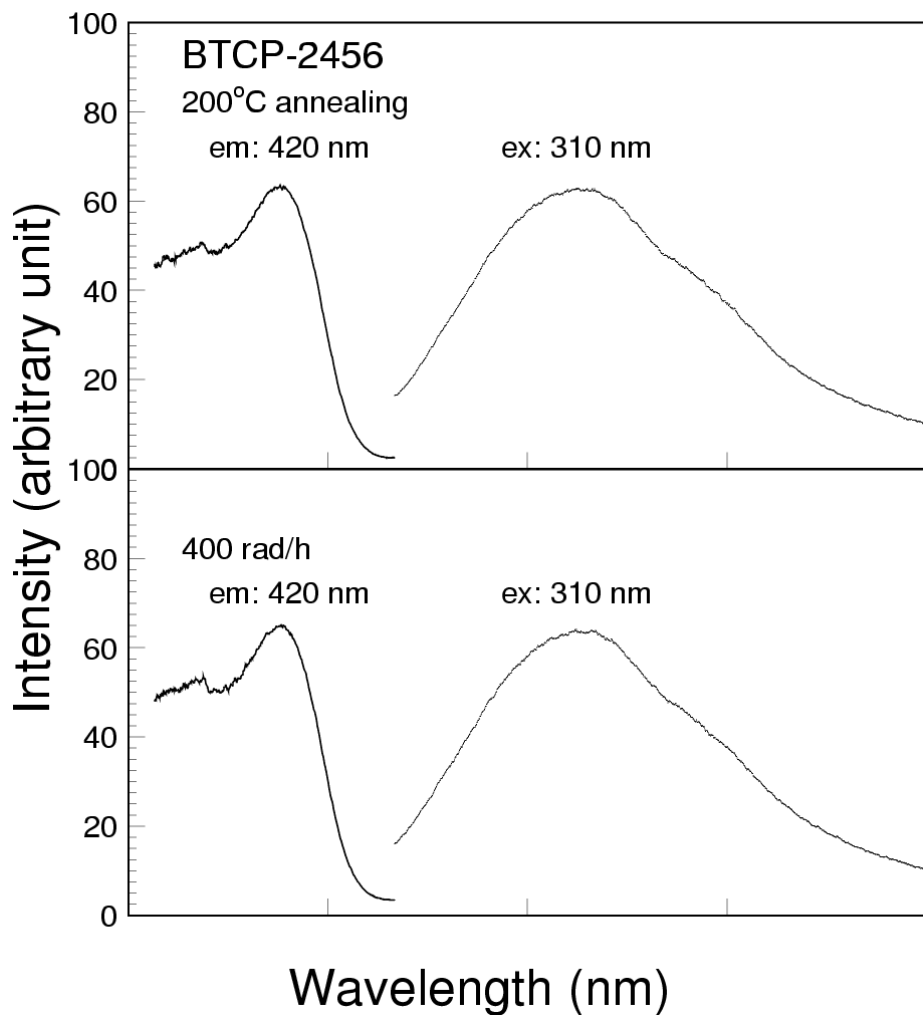


Photo Luminescence (350-550 nm)

Difference bin by bin in % with area normalization

Systematic Uncertainties: 1%

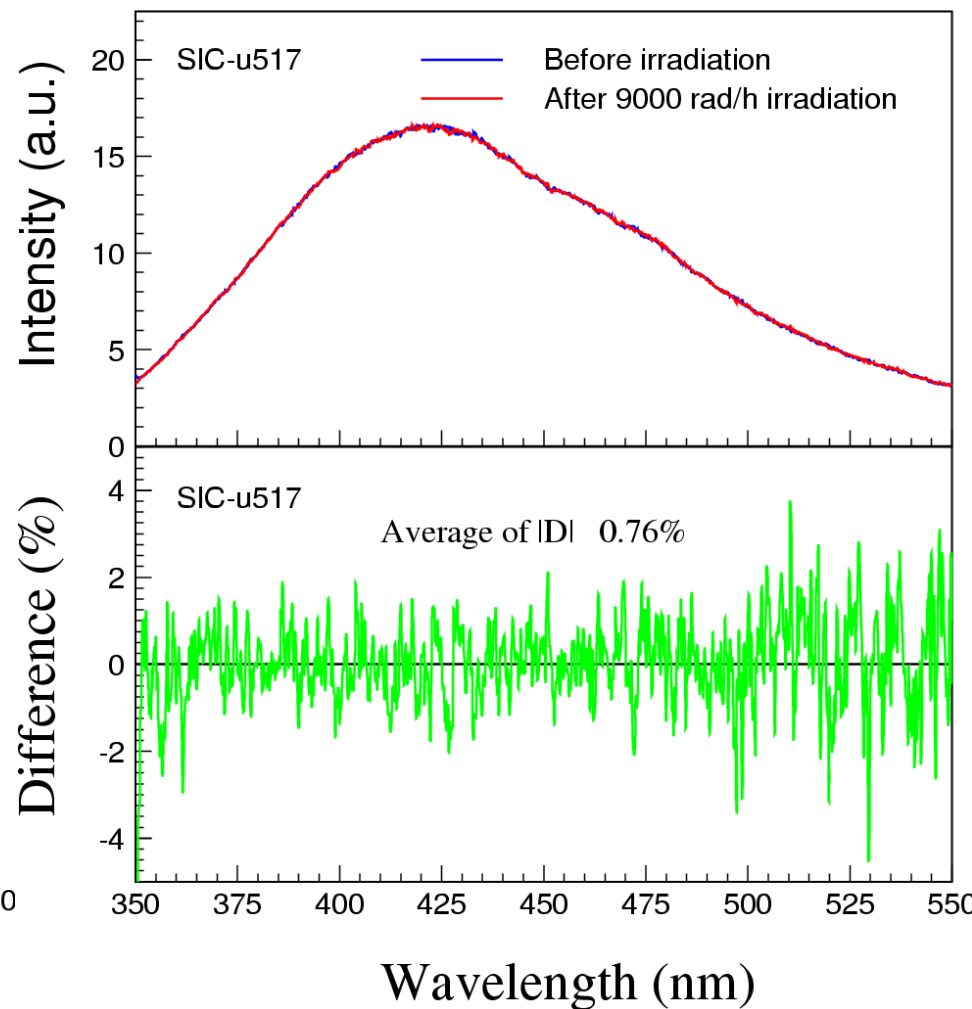
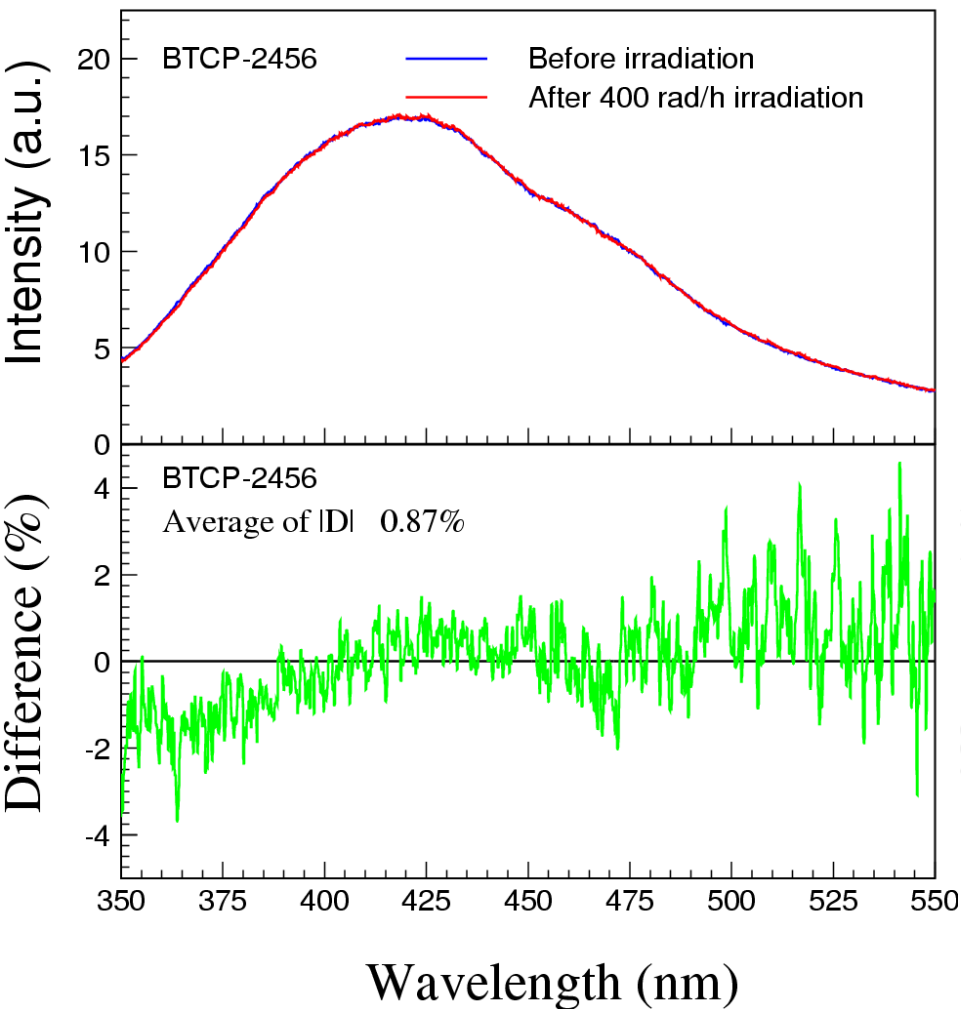
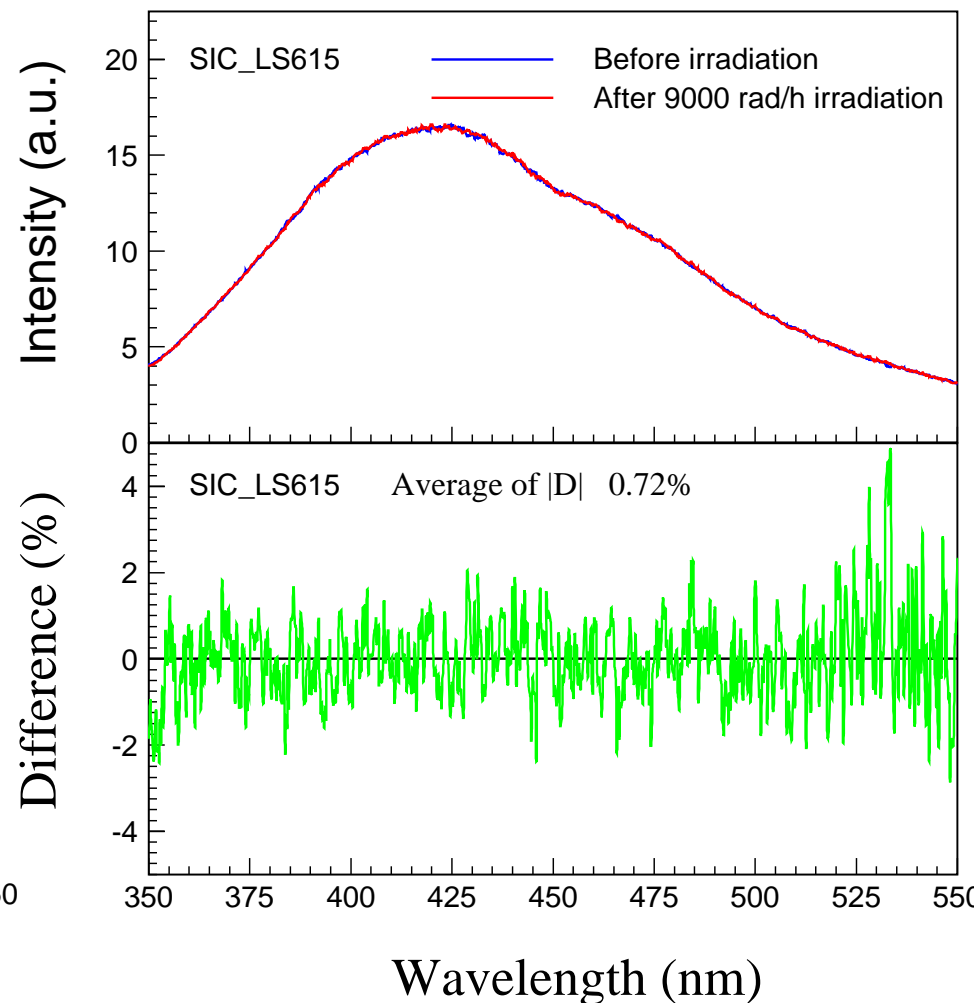
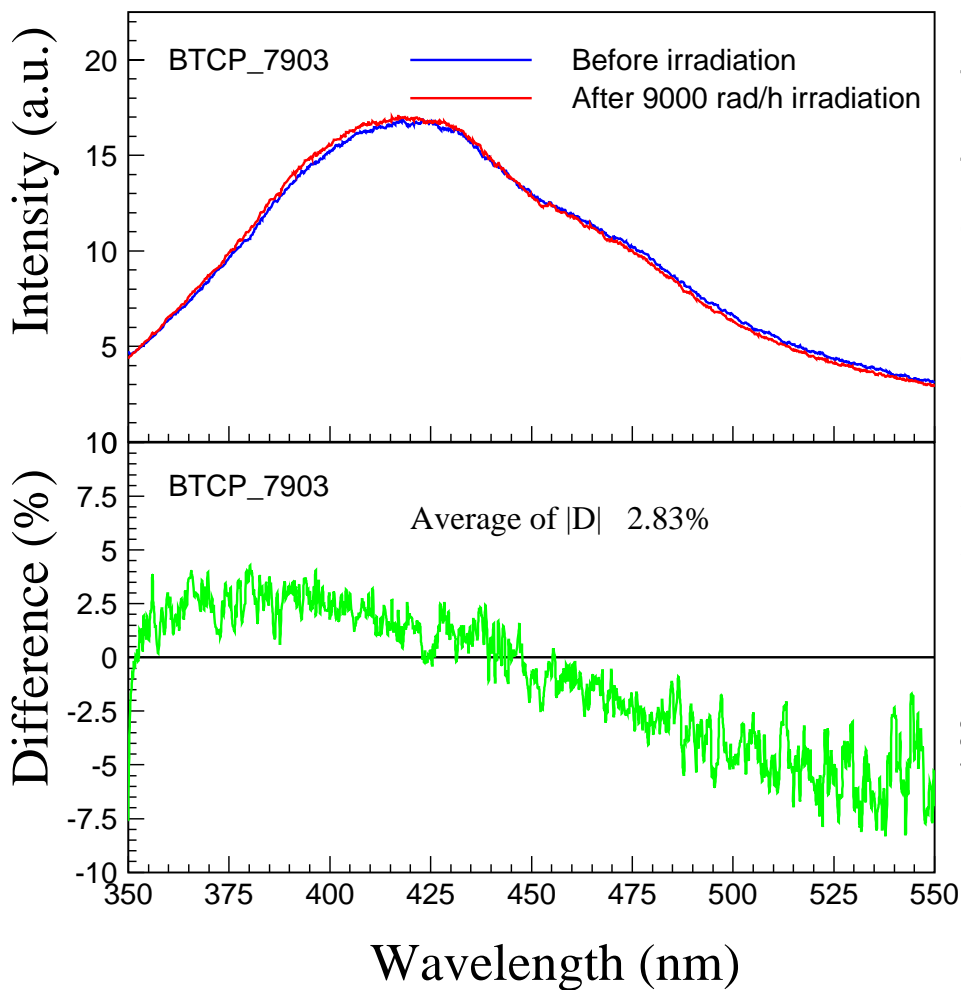


Photo Luminescence

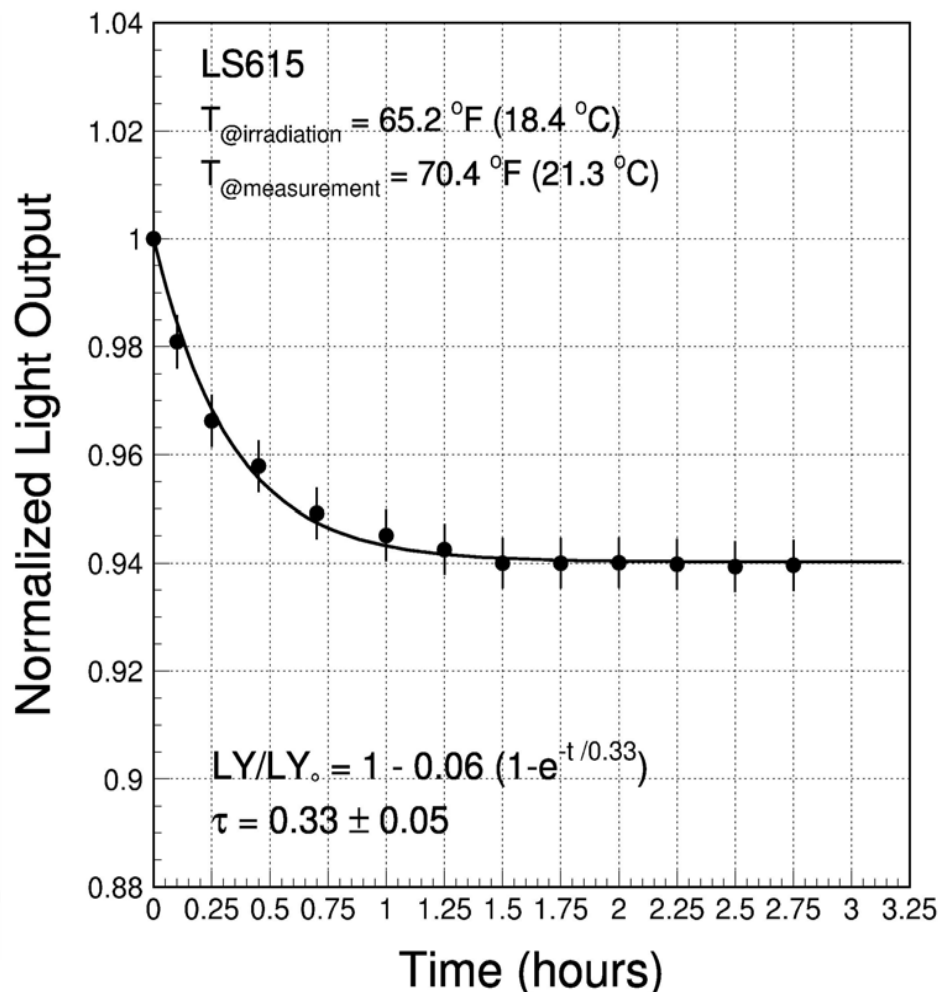
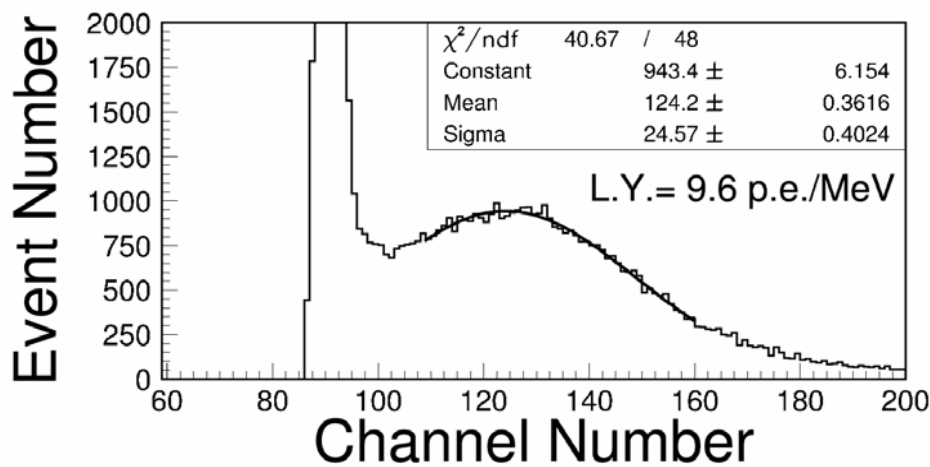
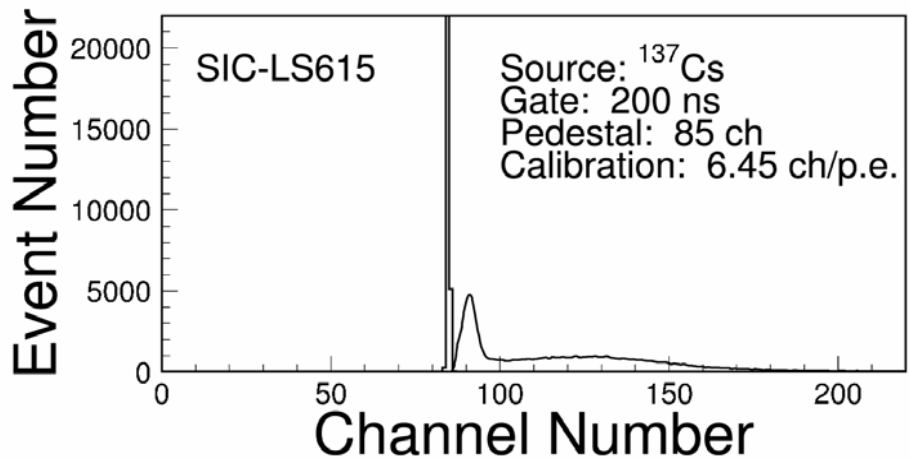
Difference bin by bin in % with area normalization

Systematic Uncertainties: 2%



Light Output Measurement

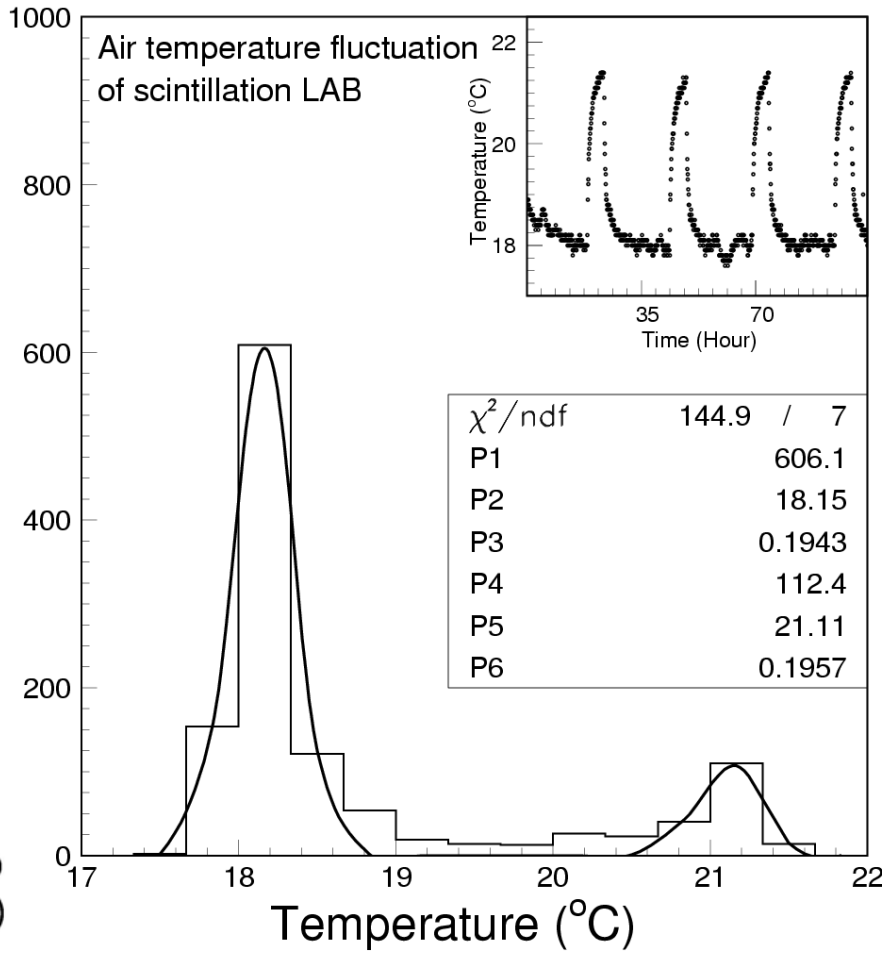
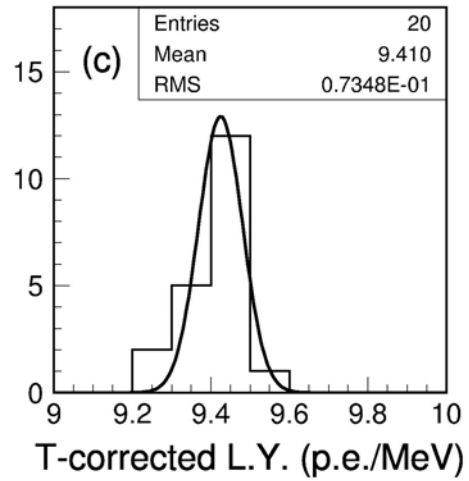
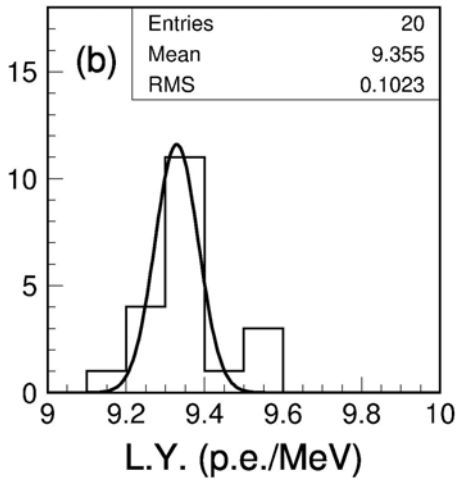
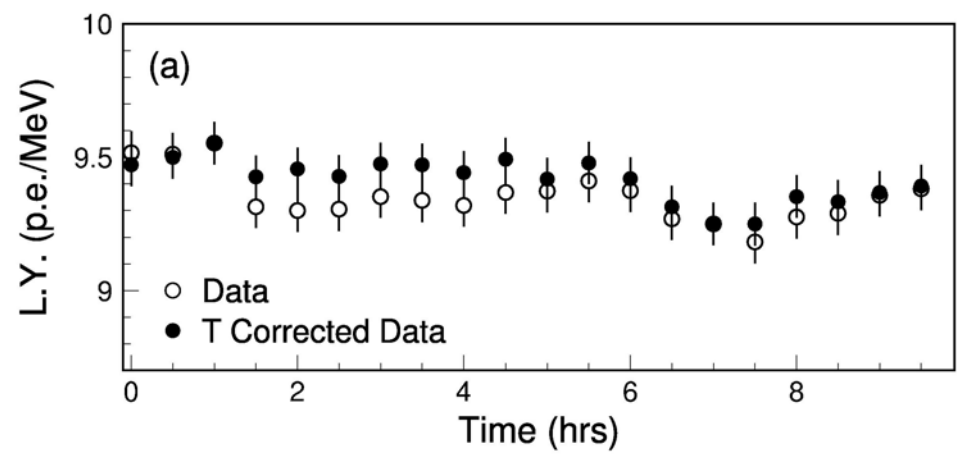
Corrections must be implemented for time of less than one hour after irradiation if there is temperature change.



Systematic Uncertainty: 1%

With stringent control and temperature corrections

L.Y. Zhang *et al.*, IEEE Trans. Nucl. Sci. **NS-48** (2001) 372





Summary



- 3 issues may cause confusion in laboratory characterization for PWO crystals:
 - Birefringence affects transmittance, photo luminescence and light output;
 - Dim scintillation light affects photo luminescence and light output;
 - Temperature dependent scintillation affects light output.
- With stringent and careful control systematic uncertainties can be reduced to 0.3%, 1% and 1% for transmittance, emission and light output measurement respectively.